Prüfbericht-Nr.: *Test report no.:*	**CN24RTIB 001**	**Auftrags-Nr.:** *Order no.:*	**168502657**	Seite 1 von 11 *Page 1 of 11*
Kunden-Referenz-Nr.: *Client reference no.:*	**N/A**	**Auftragsdatum:** *Order date:*	2024-09-03	
Auftraggeber: *Client:*	**WiseConn IP GmbH** Schochenmühlestrasse 4 6340, Baar, Switzerland			
Prüfgegenstand: *Test item:*	LoRa control and monitoring node			
Bezeichnung / Typ-Nr.: *Identification / Type no.:*	RF-V1-900-2LATCH-BATT, RF-V1-900-2LATCH-SOLAR RF-V1-900-4LATCH-BATT, RF-V1-900-4LATCH-SOLAR (Trademark: WiseConn)			
Auftrags-Inhalt: *Order content:*	Test Report			
Prüfgrundlage: *Test specification:*	CFR Title 47 FCC, Part 15, Subpart B ICES-003 Issue 7 October 2020			

Wareneingangsdatum: *Date of sample receipt:*	2024-10-17
Prüfmuster-Nr.: *Test sample no:*	A003836239-004
Prüfzeitraum: *Testing period:*	2024-10-17 - 2024-12-10
Ort der Prüfung: *Place of testing:*	TÜV Rheinland (Shenzhen) Co., Ltd.
Prüflaboratorium: *Testing laboratory:*	TÜV Rheinland (Shenzhen) Co., Ltd.
Prüfergebnis*: *Test result*:*	Pass

geprüft von: *tested by:*	X Hardy Suo	**genehmigt von:** *authorized by:*	X Lin Lin
Datum: *Date:* 2025-02-10		**Ausstellungsdatum:** *Issue date:* 2025-02-10	
Stellung / Position	Sachverständige(r)/Expert	**Stellung** / Position	Sachverständige(r)/Expert

Sonstiges /
Other:

Zustand des Prüfgegenstandes bei Anlieferung: *Condition of the test item at delivery:*	Prüfmuster vollständig und unbeschädigt *Test item complete and undamaged*

* Legende:	P(ass) = entspricht o.g. Prüfgrundlage(n)	F(ail) = entspricht nicht o.g. Prüfgrundlage(n)	N/A = nicht anwendbar	N/T = nicht getestet
** Legend:*	*P(ass) = passed a.m. test specification(s)*	*F(ail) = failed a.m. test specification(s)*	*N/A = not applicable*	*N/T = not tested*

Anmerkungen
Remarks

1	Alle eingesetzten Prüfmittel waren zum angegebenen Prüfzeitraum gemäß eines festgelegten Kalibrierungsprogramms unseres Prüfhauses kalibriert. Sie entsprechen den in den Prüfprogrammen hinterlegten Anforderungen. Die Rückverfolgbarkeit der eingesetzten Prüfmittel ist durch die Einhaltung der Regelungen unseres Managementsystems gegeben. Detaillierte Informationen bezüglich Prüfkonditionen, Prüfequipment und Messunsicherheiten sind im Prüflabor vorhanden und können auf Wunsch bereitgestellt werden. *The equipment used during the specified testing period was calibrated according to our test laboratory calibration program. The equipment fulfils the requirements included in the relevant standards. The traceability of the test equipment used is ensured by compliance with the regulations of our management system.* *Detailed information regarding test conditions, equipment and measurement uncertainty is available in the test laboratory and could be provided on request.*
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3	Prüfklausel mit der Note * wurden an qualifizierte Unterauftragnehmer vergeben und sind unter der jeweiligen Prüfklausel des Berichts beschrieben. Abweichungen von Prüfspezifikation(en) oder Kundenanforderungen sind in der jeweiligen Prüfklausel im Bericht aufgeführt. *Test clauses with remark of * are subcontracted to qualified subcontractors and descripted under the respective test clause in the report.* *Deviations of testing specification(s) or customer requirements are listed in specific test clause in the report.*
4	Die Entscheidungsregel für Konformitätserklärungen basierend auf numerischen Messergebnisen in diesem Prüfbericht basiert auf der "Null-Grenzwert-Regel" und der "Einfachen Akzeptanz" gemäß ILAC G8:2019 und IEC Guide 115:2021, es sei denn, in der auf Seite 1 dieses Berichts genannten angewandten Norm ist etwas anderes festgelegt oder vom Kunden gewünscht. Dies bedeutet, dass die Messunsicherheit nicht berücksichtigt wird und daher auch nicht im Prüfbericht angegeben wird. Zu weiteren Informationen bezueglich des Risikos durch diese Entscheidungsregel siehe ILAC G8:2019. The decision rule for statements of conformity, based on numerical measurement results, in this test report is based on the “Zero Guard Band Rule” and “Simple Acceptance” in accordance with ILAC G8:2019 and IEC Guide 115:2021, unless otherwise specified in the applied standard mentioned on Page 1 of this report or requested by the customer. This means that measurement uncertainty is not taken in account and hence also not declared in the test report. For additional information to the resulting risk based of this decision rule please refer to ILAC G8:2019.

Test Summary

5.1 Radiated emissions
RESULT: Pass

Contents

1 General Remarks

1.1 Complementary Materials

All attachments are integral parts of this test report. This applies especially to the following appendix:

Appendix A: Test Result.
Appendix B: Test Setup Photos.

2 Test Sites

2.1 Test Facilities

TÜV Rheinland (Shenzhen) Co., Ltd.

No. 362 Huanguan Road Middle, Longhua District, 518110, Shenzhen, P. R. China.

2.2 List of Test and Measurement Instruments

Table 1: List of Test and Measurement Equipment

Radiated Emission (3m chamber)				
Equipment	**Manufacturer**	**Model No.**	**Serial No.**	**Cal. Until**
3m SAC	ETS-Lindgren	SAC3	CT001632-Q1362	2025-07-22
EMI Test Receiver	R&S	ESR7	102111	2025-08-18
Horn Antenna	R&S	HF907	102706	2025-09-01
Preamplifier (1-18GHz)	R&S	SCU-18F	180076	2025-10-11
Active magnetic loop antenna	SCHWARZBECK	FMZB1519B	00080	2025-09-01
Trilog-Broadband antenna	SCHWARZBECK	VULB9168	0945	2025-07-17
EMC32 test software	R&S	EMC32(Ver.10.60.20)	N/A	N/A

2.3 Traceability

All measurement equipment calibrations are traceable to NIM (National Institute of Metrology) or where calibration is performed in other countries, to equivalent nationally recognized standards organizations.

2.4 Calibration

Equipment requiring calibration is calibrated periodically by the manufacturer or according to manufacturer's specifications. Additionally all equipment is verified for proper performance on a regular basics using in house standards or comparisons.

2.5 Measurement Uncertainty

The estimated combined standard uncertainty for radiated emissions and conducted emissions measurements as below table

Parameter	Uncertainty
Mains Harmonic	± 4.60 %
Voltage Fluctuations & Flicker	± 0.64 %
Radiated Emission (3m SAC), 30MHz to 1000MHz	± 4.52 dB
Radiated Emission (3m SAC), above 1000MHz	± 4.37 dB
Conducted Emission, (9kHz to 150kHz)/(150kHz to 30MHz)	± 3.70 dB / ± 3.30 dB

2.6 Location of Original Data

The original copies of all test data taken during actual testing were at this report and delivered to the applicant. A copy has been retained in the TÜV Rheinland (Shenzhen) file for certification follow-up purposes.

2.7 Status of Facility Used for Testing

The TÜV Rheinland (Shenzhen) Co., Ltd. facility located at No. 362 Huanguan Road Middle, Longhua District, 518110, Shenzhen, P. R. China. is listed on the US Federal Communications Commission list of facilities approved to perform measurements.

3 General Product Information

3.1 Product Function and Intended Use

The EUT is a LoRa control and monitoring node which supports Lora, Bluetooth LE and NFC wireless technologies.

Model List:

Model No.	Power Supply	Digital Inputs	Latching Outputs
RF-V1-900-2LATCH-BATT	31200mAh Battery	4 Digital Inputs: V1 IN V2 IN V3 IN V4 IN	2 Latching Outputs: V1 V2
RF-V1-900-2LATCH-SOLAR	13000mAh Battery and Solar Panel	4 Digital Inputs: V1 IN V2 IN V3 IN V4 IN	2 Latching Outputs: V1 V2
RF-V1-900-4LATCH-BATT	31200mAh Battery	4 Digital Inputs: V1 IN V2 IN V3 IN V4 IN	4 Latching Outputs: V1 V2 V3 V4
RF-V1-900-4LATCH-SOLAR	13000mAh Battery and Solar Panel	4 Digital Inputs: V1 IN V2 IN V3 IN V4 IN	4 Latching Outputs: V1 V2 V3 V4

For details refer to the User Manual, Technical Description and Circuit Diagram.

3.2 Ratings and System Details

Table 2: Technical Specification of EUT

General Information of EUT	Value
Kind of Equipment:	LoRa control and monitoring node
Type Designation:	RF-V1-900-2LATCH-BATT, RF-V1-900-2LATCH-SOLAR RF-V1-900-4LATCH-BATT, RF-V1-900-4LATCH-SOLAR
Operating Voltage:	DC 5V (31200mAh Battery, or 13000mAh Battery and Solar Panel)
Testing Voltage:	DC 5V
Operating Temperature Range:	-10 °C ~ +55 °C

3.3 Independent Operation Modes

The basic operation modes are:

A. On, Normal operation

3.4 Noise Generating and Noise Suppressing Parts

Refer to Circuit Diagram for further details.

3.5 Submitted Documents

- Block Diagram
- Schematics
- Photo Document
- User Manual

4 Test Set-up and Operation Modes

4.1 Principle of Configuration Selection

Emission: The equipment under test (EUT) was configured to measure its highest possible radiation level. The test modes were adapted accordingly in reference to the instructions for use.

4.2 Test Operation and Test Software

Test operation refers to test setup in chapter 5. All testing were performed according to the procedures in ANSI C63.4: 2014.

According to clause 3.1, all test were applied on model RF-V1-900-4LATCH-BATT.

4.3 Special Accessories and Auxiliary Equipment

Table 3: List of Accessories and Auxiliary Equipment

Description	Manufacturer	Model	S/N
Cement resistance dummy load (5W)	/	/	/
Metal resistance dummy load (5W)	/	/	/
Sensor	Rika Sensors	RK200-03	/

4.4 Countermeasures to Achieve EMC Compliance

The test sample which has been tested contained the noise suppression parts as described in the Technical Construction File (TCF). No additional measures were employed to achieve compliance.

4.5 Test Setup Diagram

Diagram of Measurement Configuration for Radiation Test (Below 1GHz)

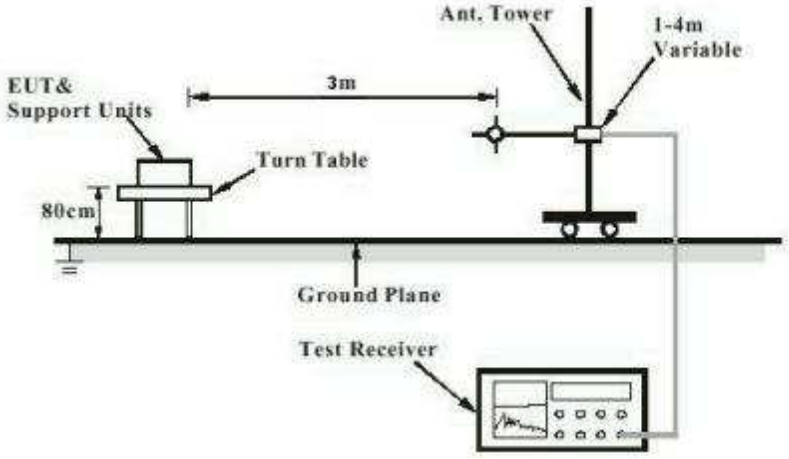
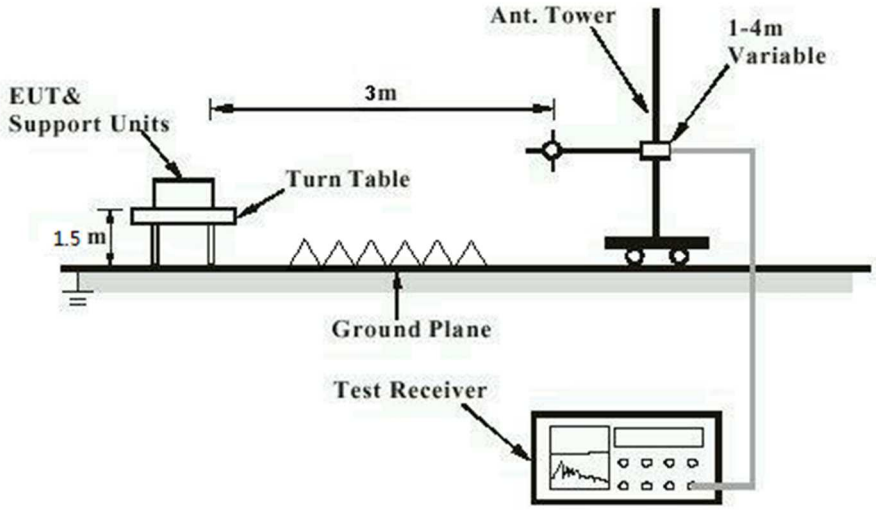


Diagram of Measurement Configuration for Radiation Test (Above 1GHz)



5 Test Results

5.1 Radiated Emission

RESULT: **Pass**

Test Specification

Test standard	:	FCC Part 15.109(a) ICES-003 Issue 7, Clause 3.2.2
Basic standard	:	ANSI C63.4: 2014
Frequency range	:	30MHz to 5th highest fundamental frequency
Classification	:	Class B
Limit	:	FCC Part 15.109(a) ICES-003 Table 2 & Table 4
Kind of test site	:	3m Semi-anechoic Chamber & 3m Full-anechoic Chamber

Test Setup

Date of testing	:	2024-10-17 - 2024-12-10
Input voltage	:	DC 5V
Operation mode	:	A
Earthing	:	Not Connected
Ambient temperature	:	Refer to test data
Relative humidity	:	Refer to test data
Atmospheric pressure	:	Refer to test data

For the measurement records, refer to appendix A.

Remark 1: The limit of below radiated emission test data is from FCC part 15.109, it also meet the limit of ICES-003 issue 7.

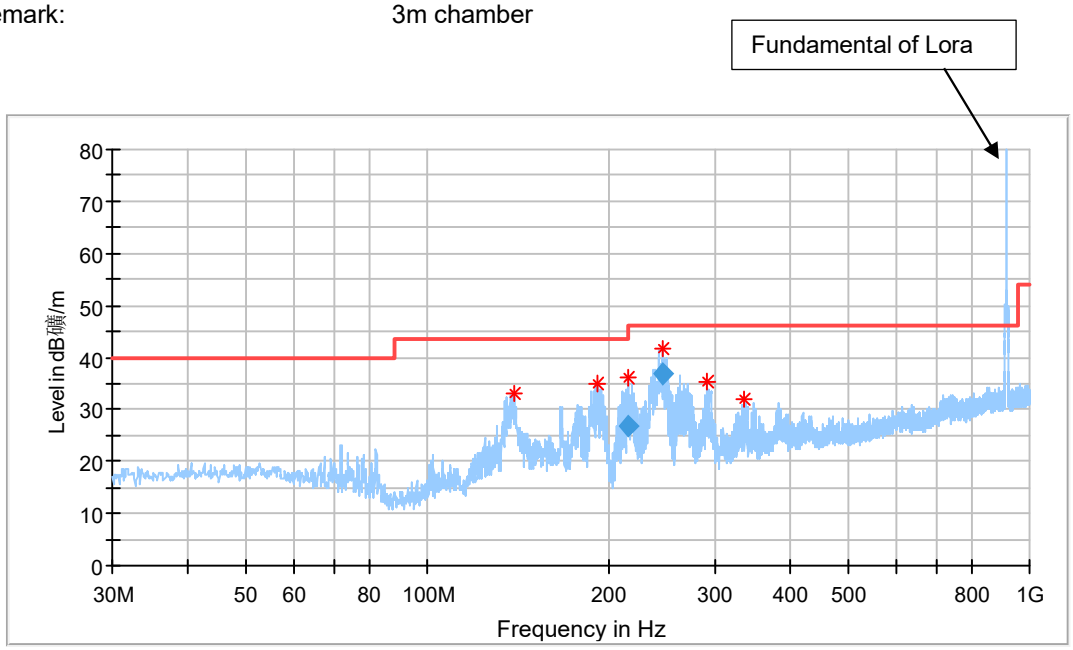
6 List of Tables

Appendix A: Test Results of EMC Requirements

Appendix A.1: Test Results of Radiated Emission, Below 1GHz

EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with integral ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part15B
Test By:/Review By:	Simon Feng/ Shower Dai
Tem./Hum./Pressure:	24.1°C /52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

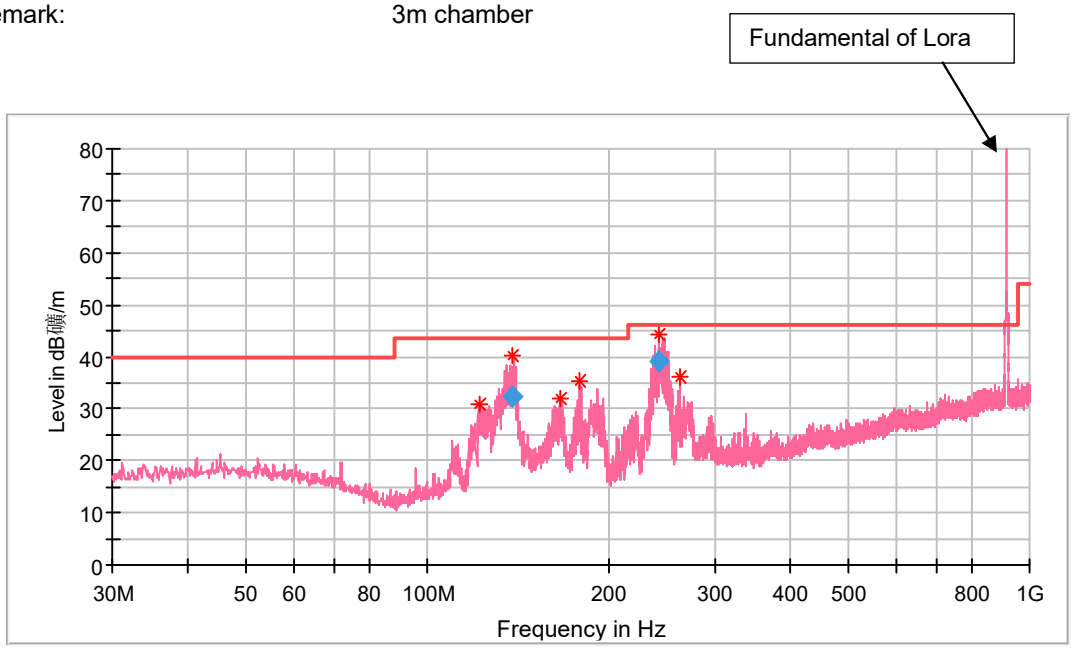
Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
139.125000	33.16	43.50	10.34	300.0	H	107.0	20.0
190.923000	35.06	43.50	8.44	100.0	H	94.0	17.7
215.145000	36.11	43.50	7.39	200.0	H	16.0	17.4
246.561000	41.59	46.00	4.41	100.0	H	250.0	19.2
291.027000	35.43	46.00	10.57	100.0	H	225.0	20.9
334.289000	32.12	46.00	13.88	100.0	H	36.0	22.2

Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
215.145000	26.94	43.50	16.56	1000.0	120.000	200.0	H	16.0	17.4
246.561000	36.81	46.00	9.19	1000.0	120.000	100.0	H	250.0	19.2

EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with integral ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part15B
Test By:/Review By:	Simon Feng/ Shower Dai
Tem./Hum./Pressure:	24.1°C /52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

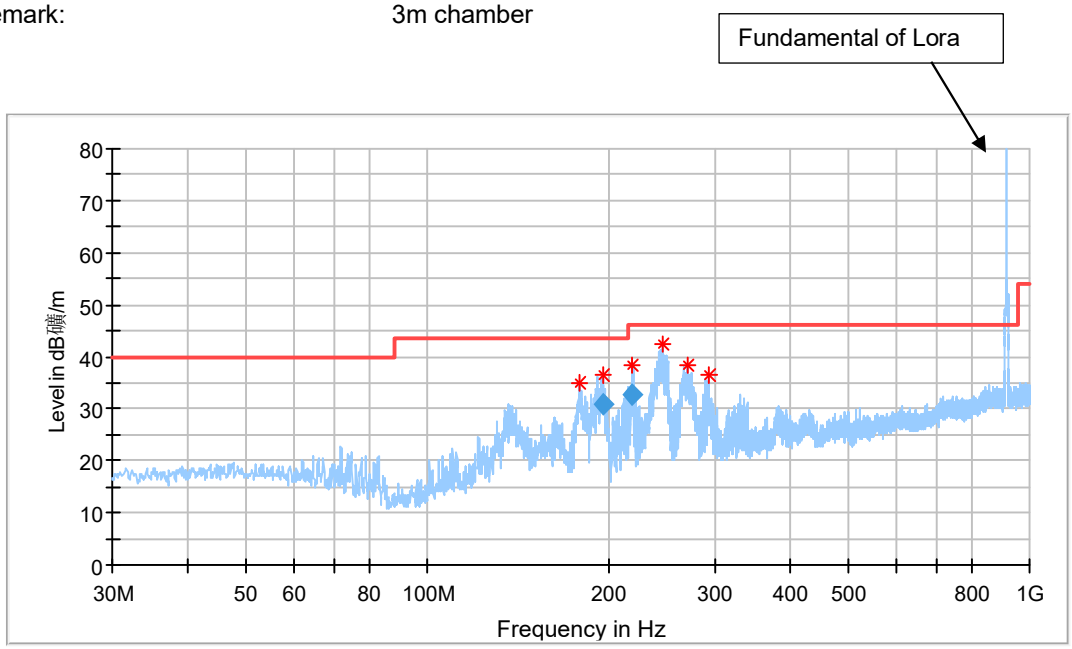
Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
121.568000	30.72	43.50	12.78	100.0	V	255.0	18.3
138.468000	40.21	43.50	3.29	100.0	V	181.0	20.0
166.673000	32.05	43.50	11.45	100.0	V	177.0	20.4
178.701000	35.45	43.50	8.05	100.0	V	177.0	19.2
242.692000	44.27	46.00	1.73	100.0	V	0.0	19.1
262.218000	36.07	46.00	9.93	100.0	V	353.0	19.7

Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
138.468000	32.27	43.50	11.23	1000.0	120.000	100.0	V	181.0	20.0
242.692000	39.07	46.00	6.93	1000.0	120.000	100.0	V	0.0	19.1

EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with external ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part15B
Test By:/Review By:	Simon Feng/ Shower Dai
Tem./Hum./Pressure:	24.1°C /52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

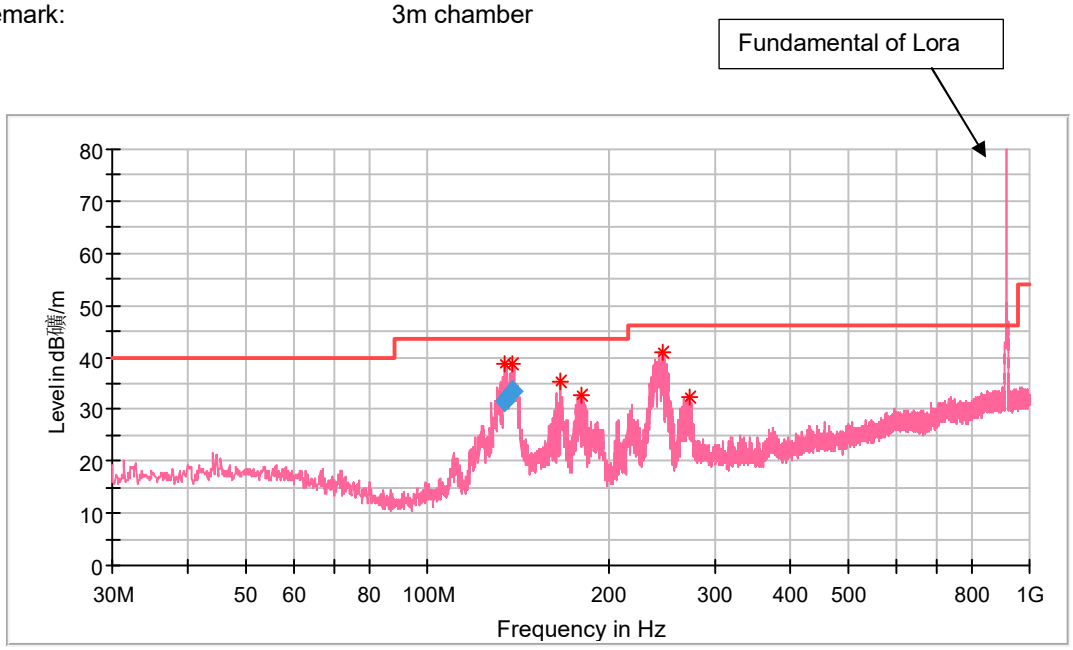
Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
178.895000	34.80	43.50	8.70	100.0	H	211.0	19.2
194.928000	36.54	43.50	6.96	200.0	H	236.0	17.4
219.230000	38.50	46.00	7.50	200.0	H	89.0	17.4
246.601000	42.60	46.00	3.40	100.0	H	17.0	19.2
270.075000	38.14	46.00	7.86	100.0	H	264.0	20.1
294.228000	36.35	46.00	9.65	100.0	H	42.0	21.0

Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
194.928000	30.78	43.50	12.72	1000.0	120.000	200.0	H	236.0	17.4
219.230000	32.86	46.00	13.14	1000.0	120.000	200.0	H	89.0	17.4

EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with external ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part15B
Test By:/Review By:	Simon Feng/ Shower Dai
Tem./Hum./Pressure:	24.1°C 52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
134.669000	38.61	43.50	4.89	100.0	V	344.0	19.6
138.372000	38.83	43.50	4.67	100.0	V	212.0	20.0
166.673000	35.53	43.50	7.97	100.0	V	329.0	20.4
179.768000	32.60	43.50	10.90	100.0	V	329.0	19.1
246.795000	40.79	46.00	5.21	200.0	V	336.0	19.2
273.082000	32.31	46.00	13.69	100.0	V	289.0	20.3

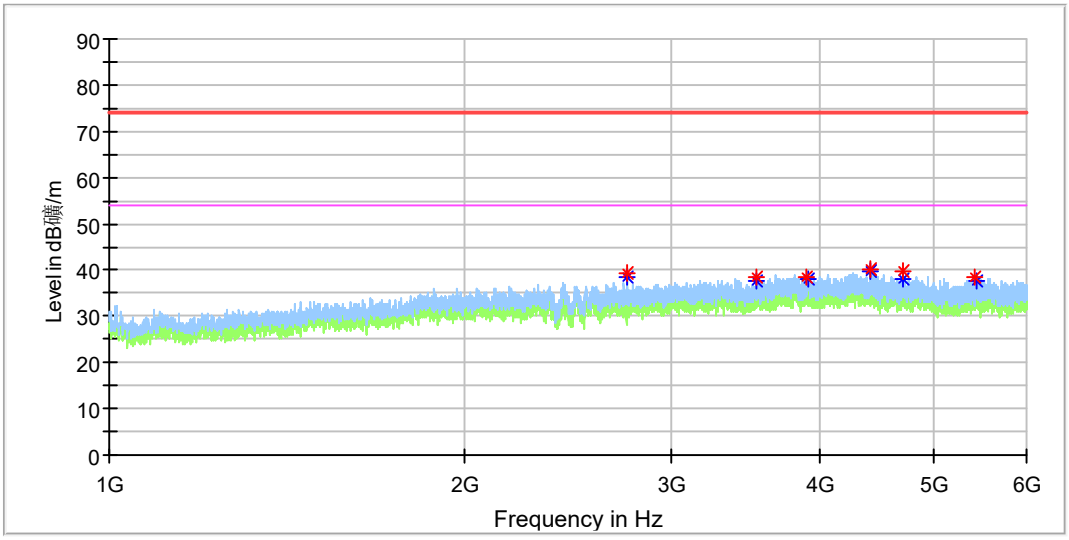
Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
134.669000	31.76	43.50	11.74	1000.0	120.000	100.0	V	344.0	19.6
138.372000	33.36	43.50	10.14	1000.0	120.000	100.0	V	212.0	20.0

Appendix A.2: Test Results of Radiated Emission, Above 1GHz

EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with integral ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part 15B
Test By:/Review By:	Junhua/ Shower Dai
Tem./Hum./Pressure:	24.1°C/52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

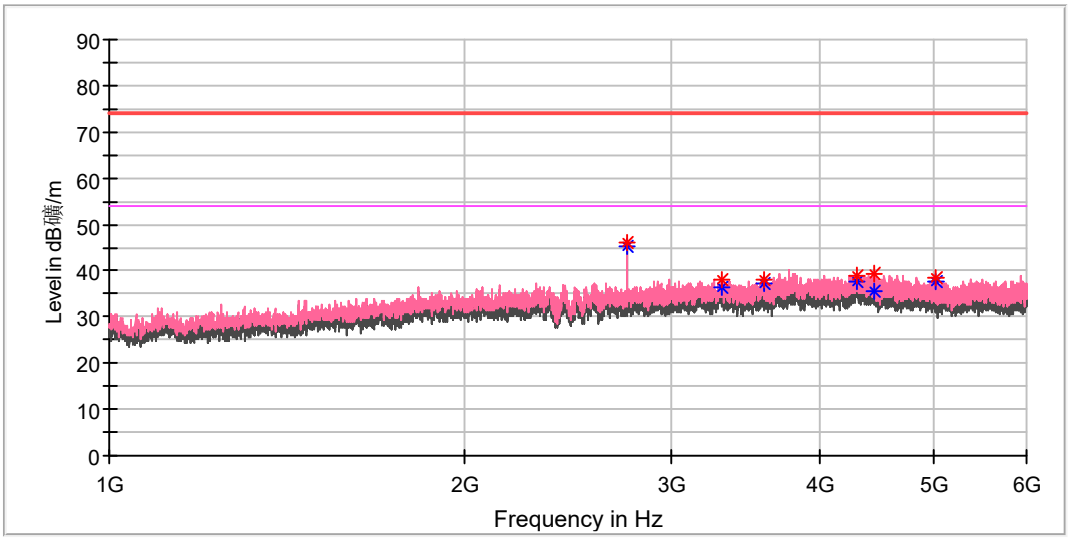
Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
2746.500000	---	54.00	15.60	100.0	H	0.0	-4.0
2746.500000	39.34	74.00	34.66	100.0	H	0.0	-4.0
3542.000000	38.56	74.00	35.44	100.0	H	178.0	-1.6
3542.000000	---	54.00	16.27	100.0	H	178.0	-1.6
3907.000000	38.66	74.00	35.34	100.0	H	22.0	-0.4
3913.500000	---	54.00	16.09	100.0	H	336.0	-0.4
4428.500000	---	54.00	14.43	100.0	H	107.0	0.4
4428.500000	40.04	74.00	33.96	100.0	H	107.0	0.4
4718.000000	39.58	74.00	34.42	100.0	H	149.0	0.0
4718.000000	---	54.00	15.92	100.0	H	149.0	0.0
5419.500000	38.69	74.00	35.31	100.0	H	186.0	1.1
5439.000000	---	54.00	16.32	100.0	H	60.0	1.0

Final_Result

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
---	---	---	---	---	---	---		---	---

EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with integral ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part 15B
Test By:/Review By:	Junhua/ Shower Dai
Tem./Hum./Pressure:	24.1°C/52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
2746.500000	---	54.00	8.93	100.0	V	131.0	-4.0
2746.500000	46.01	74.00	27.99	100.0	V	131.0	-4.0
3301.500000	---	54.00	17.78	100.0	V	266.0	-1.7
3301.500000	38.26	74.00	35.74	100.0	V	266.0	-1.7
3594.500000	---	54.00	16.71	100.0	V	46.0	-1.3
3594.500000	38.26	74.00	35.74	100.0	V	46.0	-1.3
4298.000000	38.78	74.00	35.22	100.0	V	229.0	0.8
4309.000000	---	54.00	16.19	100.0	V	46.0	0.8
4454.500000	---	54.00	18.31	100.0	V	101.0	0.7
4454.500000	39.53	74.00	34.47	100.0	V	101.0	0.7
5021.000000	---	54.00	16.51	100.0	V	157.0	0.5
5021.000000	38.71	74.00	35.29	100.0	V	157.0	0.5

Final_Result

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
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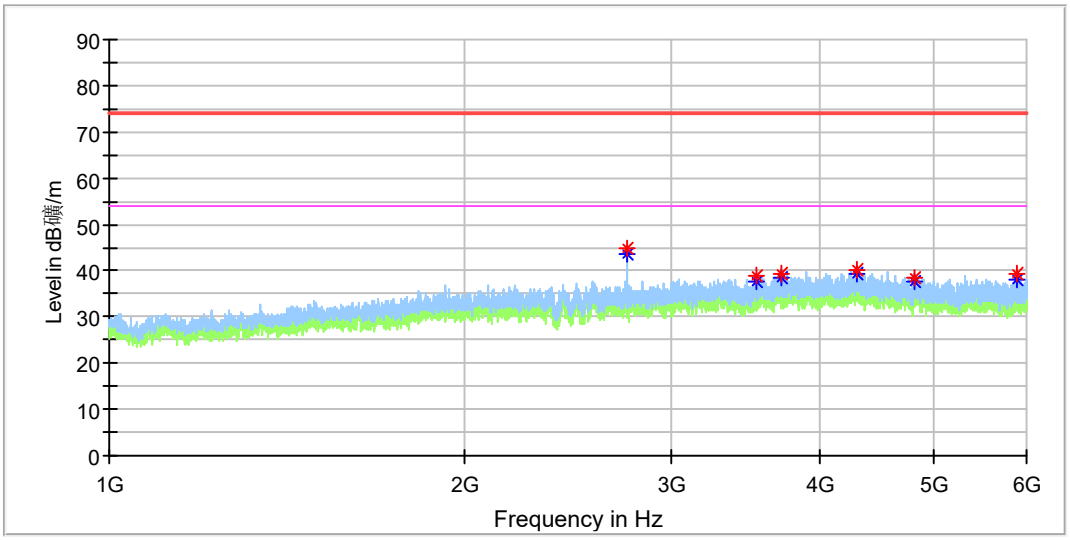
EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with external ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part 15B
Test By:/Review By:	Junhua/ Shower Dai
Tem./Hum./Pressure:	24.1°C/52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
2746.500000	44.71	74.00	29.29	100.0	H	221.0	-4.0
2746.500000	---	54.00	10.57	100.0	H	221.0	-4.0
3532.500000	39.00	74.00	35.00	100.0	H	243.0	-1.7
3532.500000	---	54.00	16.14	100.0	H	243.0	-1.7
3713.500000	---	54.00	15.30	100.0	H	146.0	-0.5
3713.500000	39.33	74.00	34.67	100.0	H	146.0	-0.5
4309.500000	40.29	74.00	33.71	100.0	H	221.0	0.8
4309.500000	---	54.00	14.67	100.0	H	221.0	0.8
4830.000000	38.50	74.00	35.50	100.0	H	55.0	0.6
4830.000000	---	54.00	16.49	100.0	H	55.0	0.6
5880.000000	39.24	74.00	34.76	100.0	H	281.0	1.4
5880.000000	---	54.00	15.91	100.0	H	281.0	1.4

Final_Result

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
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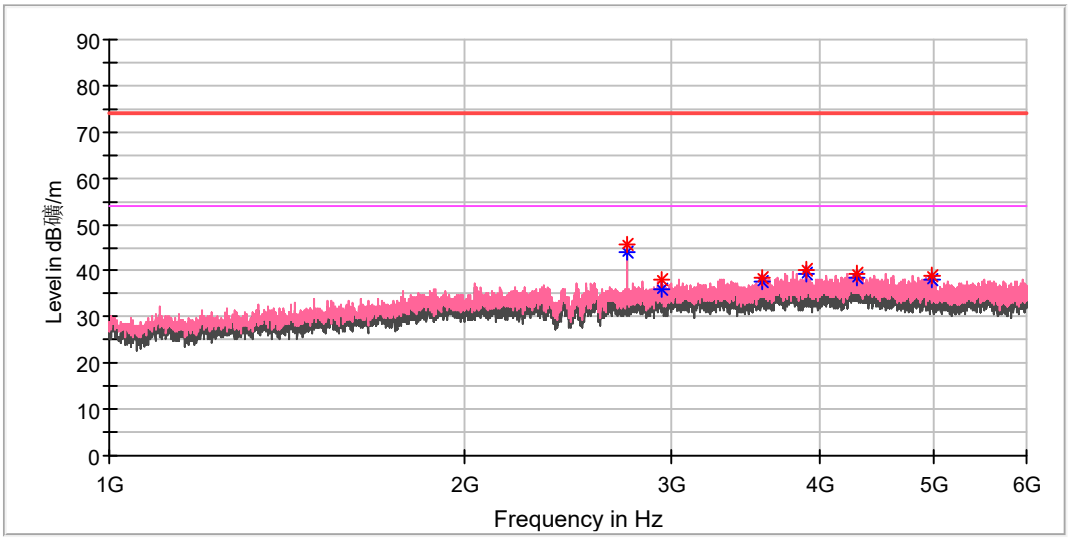
EUT Information

EUT Name:	LoRa control and monitoring node
Order Number:	168502657(P01591027)
Model:	RF-V1-900-4LATCH-BATT
Test Mode:	On, Normal operation (MN: RF-V1-900-4LATCH-BATT) with terminal node devices and with external ANT
Test Voltage:	DC 5V
Test Standard:	FCC Part 15B
Test By:/Review By:	Junhua/ Shower Dai
Tem./Hum./Pressure:	24.1°C/52.3%/101kPa
Remark:	3m chamber



Critical_Freqs

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
2747.000000	45.55	74.00	28.45	100.0	V	65.0	-3.9
2747.000000	---	54.00	9.96	100.0	V	65.0	-3.9
2936.000000	38.11	74.00	35.89	100.0	V	42.0	-3.2
2936.000000	---	54.00	17.99	100.0	V	42.0	-3.2
3580.500000	38.45	74.00	35.55	100.0	V	330.0	-1.4
3580.500000	---	54.00	16.35	100.0	V	330.0	-1.4
3896.500000	40.20	74.00	33.80	100.0	V	243.0	-0.4
3896.500000	---	54.00	14.60	100.0	V	243.0	-0.4
4307.500000	39.29	74.00	34.71	100.0	V	198.0	0.8
4307.500000	---	54.00	15.68	100.0	V	198.0	0.8
4988.500000	38.95	74.00	35.05	100.0	V	54.0	0.6
4988.500000	---	54.00	15.97	100.0	V	54.0	0.6

Final_Result

Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
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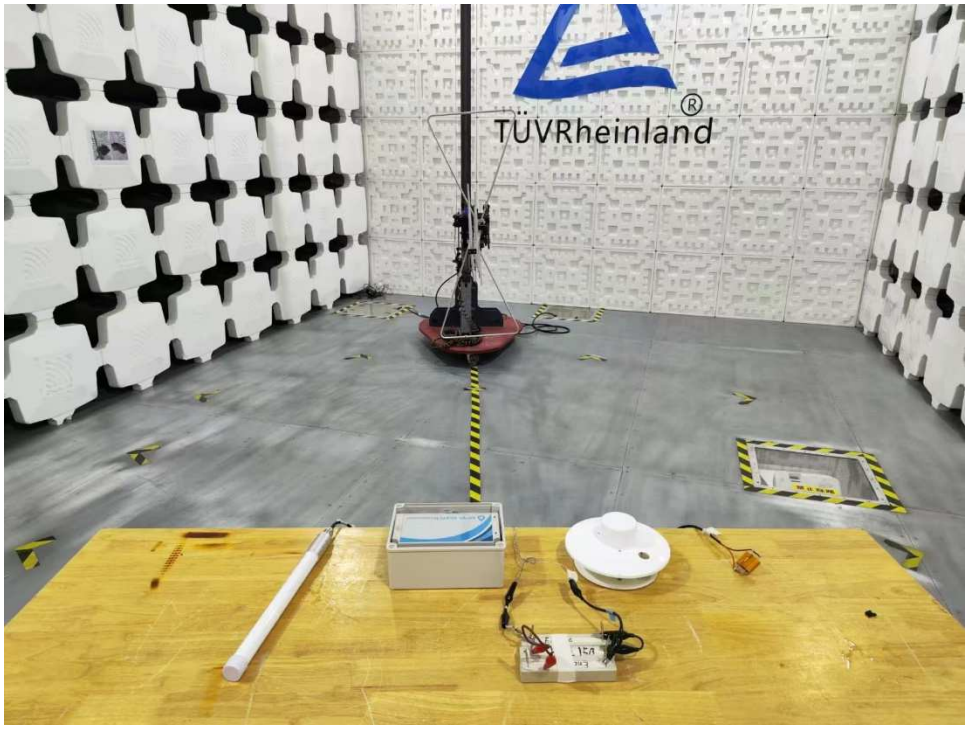
Appendix B: Photographs of the Test Set-Up Photos

Photograph 1: Set-up for Radiated Emissions, below 1GHz



Photograph 2: Set-up for Radiated Emissions, above 1GHz